Se	Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/621,387	SHIRAI ET AL.	
Examiner	Art Unit	
John L. Goodrow	1756	

SEARCHED			
Class	Subclass	Date	Examiner
430	109.3	6/20/2005	JG
	109.4		
528	195		
	272		
525	195		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
430	109.3/.4	6/20/2005	JG
528	195/272		
525	195		
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SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY	7)
	DATE	EXMR
inventor name search	6/20/2005	JG